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PATENT, TRADEMARK AND COPYRIGHT LAW
AND RELATED FEDERAL AND ITC LITIGATION

Docket No.: 2292-0038-0 PCT

ASSISTANT COMMISSIONER FOR PATENTS
WASHINGTON, D.C. 20231

RE: Application Serial No.: 08/722,144

Applicant(s): Masaji ISHIGURO, et al

Filing Date: December 12, 1996

For: PENEM DERIVATIVES AND ANTIMICROBIAL AGENT CONTAINING THE SAME

Group No.: 1611

Examiner: BERCH

SIR:

Attached hereto for filing are the following papers:

**SUPPLEMENTAL AMENDMENT UNDER 37 CFR 1.116
and
PETITION FOR EXTENSION OF TIME**

Our check in the amount of \$ 110.00 is attached covering any required fees. In the event any variance exists between the amount enclosed and the Patent Office charges for filing the above-noted documents, including any fees required under 37 CFR 1.136 for any necessary Extension of Time to make the filing of the attached documents timely, please charge or credit the difference to our Deposit Account No. 15-0030. Further, if these papers are not considered timely filed, then a petition is hereby made under 37 C.F.R. 1.136 for the necessary extension of time. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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